

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/616,734 | Applicant(s)/Patent Under Reexamination KESKAR ET AL. | |
| | Examiner Fayyaz Alam | Art Unit 2618 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| * | A | US-5,812,950 A | 09-1998 | Tom, Wayne S. | 455/440 |
| * | B | US-6,389,288 B1 | 05-2002 | Kuwahara et al. | 455/456.6 |
| * | C | US-2003/0054833 A1 | 03-2003 | Hayduk, Matthew A. | 455/456 |
| * | D | US-6,748,195 B1 | 06-2004 | Phillips, W. Garland | 455/41.2 |
| * | E | US-2004/0259574 A1 | 12-2004 | Daniels et al. | 455/456.3 |
| * | F | US-6,925,288 B2 | 08-2005 | McDonnell et al. | 455/41.2 |
| * | G | US-6,975,874 B1 | 12-2005 | Bates et al. | 455/456.6 |
| * | H | US-7,080,402 B2 | 07-2006 | Bates et al. | 726/2 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.